

| Application/Control No. | Applicant(s)/Patent under Reexamination | | |
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| 10/743,801 | BAILEY, GEORGE R. | | |
| Examiner | . Art Unit | | |
| Sam K. Ahn | 2611 | | |

| SEARCHED | | | | | |
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| Class | Subclass | Date | Examiner | | |
| 375 | 219, 230,232 291, 278, 284 285 | 12/21 | 1 | | |
| 323 | 318,371 | | | | |
| 327 | 143,535 | | | | |
| 455 | 572,573, 570 14,22 | | | | |
| 714 | 14,22 | 12/30 | a | | |
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| | DATE | EXMR |
| ENT inventor cearch keyword and citation rearch IEEE and goode keyword and citation cearch consulted Khanh Tran, 375 P.E. | 12/21 | 4 |
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